# DATA SHEET 74LV14 Hex inverting Schmitt-trigger

INTEGRATED CIRCUITS

Product specification Supersedes data of 1997 Feb 03 IC24 Data Handbook 1998 Apr 20







# 74LV14

### **FEATURES**

- Wide operating voltage: 1.0 to 5.5 V
- Optimized for Low Voltage applications: 1.0 to 3.6 V
- $\bullet$  Accepts TTL input levels between V\_{CC} = 2.7 V and V\_{CC} = 3.6 V
- Typical V<sub>OLP</sub> (output ground bounce) < 0.8 V at V<sub>CC</sub> = 3.3 V,  $T_{amb} = 25^{\circ}C.$
- Typical V<sub>OHV</sub> (output V<sub>OH</sub> undershoot) > 2 V at V<sub>CC</sub> = 3.3 V,  $T_{amb} = 25^{\circ}C.$
- Output capability: standard
- I<sub>CC</sub> category: SSI

### QUICK REFERENCE DATA

### GND = 0 V; $T_{amb} = 25^{\circ}C$ ; $t_{f} = t_{f} \le 2.5$ ns

### **APPLICATIONS**

• Wave and pulse shapers for highly noisy environments

### DESCRIPTION

The 74LV14 is a low-voltage Si-gate CMOS device and is pin and function compatible with 74HC/HCT14.

The 74LV14 provides six inverting buffers with Schmitt-trigger action. It is capable of transforming slowly changing input signals into sharply defined, jitter-free output signals.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay nA to nY	C <sub>L</sub> = 15 pF; V <sub>CC</sub> = 3.3 V	13	ns
Cl	Input capacitance		3.5	pF
C <sub>PD</sub>	Power dissipation capacitance per gate	See Notes 1 and 2	15	pF

NOTES:

1.  $C_{PD}$  is used to determine the dynamic power dissipation (P<sub>D</sub> in  $\mu$ W)  $P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum (C_L \times V_{CC}^2 \times f_o)$  where:  $f_i = \text{input frequency in MHz; } C_L = \text{output load capacitance in pF; } \\ f_o = \text{output frequency in MHz; } V_{CC} = \text{supply voltage in V; }$  $\sum_{i=1}^{n} (C_L \times V_{CC}^2 \times f_0) = \text{sum of the outputs.}$ 2. The condition is V<sub>1</sub> = GND to V<sub>CC.</sub>

### **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
14-Pin Plastic DIL	–40°C to +125°C	74LV14 N	74LV14 N	SOT27-1
14-Pin Plastic SO	–40°C to +125°C	74LV14 D	74LV14 D	SOT108-1
14-Pin Plastic SSOP Type II	–40°C to +125°C	74LV14 DB	74LV14 DB	SOT337-1
14-Pin Plastic TSSOP Type I	–40°C to +125°C	74LV14 PW	74LV14PW DH	SOT402-1

### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1, 3, 5, 9, 11, 13	1A – 6A	Data inputs
2, 4, 6, 8, 10, 12	1Y – 6Y	Data outputs
7	GND	Ground (0 V)
14	V <sub>CC</sub>	Positive supply voltage

### **FUNCTION TABLE**

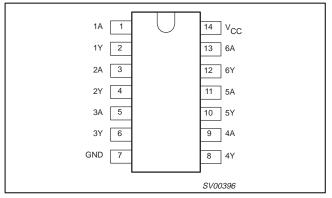
INPUT	OUTPUT
nA	nY
L	Н
н	L

NOTES:

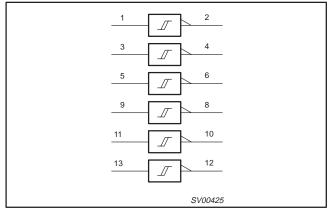
H = HIGH voltage level L = LOW voltage level

# 74LV14

### **PIN CONFIGURATION**



# LOGIC SYMBOL (IEEE/IEC)



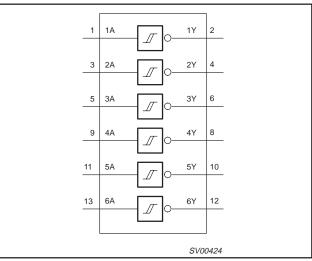
### **RECOMMENDED OPERATING CONDITIONS**

### SYMBOL PARAMETER CONDITIONS MAX UNIT MIN TYP See Note1 Vcc DC supply voltage 1.0 3.3 5.5 V 0 V $V_{I}$ Input voltage \_ $V_{CC}$ V $V_{O}$ Output voltage 0 \_ V<sub>CC</sub> Operating ambient temperature range in free See DC and AC -40 +85 °C Tamb characteristics -40 +125 air

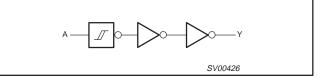
NOTE:

1. The LV is guaranteed to function down to  $V_{CC}$  = 1.0V (input levels GND or  $V_{CC}$ ); DC characteristics are guaranteed from  $V_{CC}$  = 1.2V to  $V_{CC}$  = 5.5V.

### LOGIC SYMBOL



### LOGIC DIAGRAM



74LV14

### ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>

In accordance with the Absolute Maximum Rating System (IEC 134).

Voltages are referenced to GND (ground = 0V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +7.0	V
$\pm I_{IK}$	DC input diode current	$V_{I} < -0.5 \text{ or } V_{I} > V_{CC} + 0.5 V$	20	mA
$\pm I_{OK}$	DC output diode current	$V_{\rm O}$ < -0.5 or $V_{\rm O}$ > $V_{\rm CC}$ + 0.5V	50	mA
$\pm I_{O}$	DC output source or sink current – standard outputs	$-0.5V < V_{O} < V_{CC} + 0.5V$	25	mA
$^{\pm  I_{GND},}_{\pm  I_{CC}}$	DC V <sub>CC</sub> or GND current for types with – standard outputs		50	mA
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C
P <sub>TOT</sub>	Power dissipation per package – plastic DIL – plastic mini-pack (SO) – plastic shrink mini-pack (SSOP and TSSOP)	for temperature range: -40 to +125°C above +70°C derate linearly with 12 mW/K above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	750 500 400	mW

### NOTES:

- 1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- 2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0V).

			LIMITS						
SYMBOL PARAMETER	TEST CONDITIONS	-4	0°C to +8	5°C	-40°C to	o +125°C			
			MIN	TYP <sup>1</sup>	MAX	MIN	MAX	1	
		$V_{CC}$ = 1.2V; $V_I$ = $V_{IH}$ or $V_{IL}$ , $-I_O$ = 100 $\mu$ A		1.2					
		$V_{CC}$ = 2.0V; $V_I$ = $V_{IH}$ or $V_{IL;}$ – $I_O$ = 100 $\mu$ A	1.8	2.0		1.8		]	
V <sub>OH</sub>	HIGH level output voltage; all outputs	$V_{CC}$ = 2.7V; $V_I$ = $V_{IH}$ or $V_{IL;}$ – $I_O$ = 100 $\mu$ A	2.5	2.7		2.5		V	
	·····g-,	$V_{CC}$ = 3.0V; $V_I$ = $V_{IH}$ or $V_{IL;}$ – $I_O$ = 100 $\mu$ A	2.8	3.0		2.8		]	
		$V_{CC}$ = 4.5V; $V_I$ = $V_{IH}$ or $V_{IL;}$ – $I_O$ = 100 $\mu$ A	4.3	4.5		4.3			
V <sub>OH</sub>	HIGH level output voltage;	$V_{CC}$ = 3.0V; $V_I$ = $V_{IH}$ or $V_{IL;}$ – $I_O$ = 6mA	2.40	2.82		2.20		v	
VOH STANDARD outputs		$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL;}$ – $I_{O}$ = 12mA	3.60	4.20		3.50			
		$V_{CC}$ = 1.2V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu$ A		0					
		$V_{CC}$ = 2.0V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu$ A		0	0.2		0.2	v	
V <sub>OL</sub>	LOW level output voltage; all outputs	$V_{CC}$ = 2.7V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu$ A		0	0.2		0.2		
	·····g·, ··· · ··· · ···	$V_{CC}$ = 3.0V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu$ A		0	0.2		0.2		
		$V_{CC}$ = 4.5V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu$ A		0	0.2		0.2		
V <sub>OL</sub>	LOW level output voltage;	$V_{CC}$ = 3.0V; $V_{I}$ = $V_{IH}$ or $V_{IL;}$ $I_{O}$ = 6mA		0.25	0.40		0.50	v	
VOL STANDARD outputs		$V_{CC}$ = 4.5V; $V_{I}$ = $V_{IH}$ or $V_{IL;}$ $I_{O}$ = 12mA		0.35	0.55		0.65		
I <sub>I</sub>	Input leakage current	$V_{CC}$ = 5.5V; $V_{I}$ = $V_{CC}$ or GND			1.0		1.0	μA	
I <sub>CC</sub>	Quiescent supply current; SSI	$V_{CC} = 5.5V; V_I = V_{CC} \text{ or GND}; I_O = 0$			20.0		40	μA	
$\Delta I_{CC}$	Additional quiescent supply current	$V_{CC} = 2.7V$ to 3.6V; $V_{I} = V_{CC} - 0.6V$			500		850	μA	

### NOTE:

1. All typical values are measured at  $T_{amb} = 25^{\circ}C$ .

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### **TRANSFER CHARACTERISTICS**

Voltages are referenced to GND (ground = 0 V)

		T <sub>amb</sub> (°C)						TEST CONDITIONS		
SYMBOL	PARAMETER	-40 TO +85		-40 TO +125		UNIT	V <sub>CC</sub>	WAVEFORMS		
		MIN.	TYP.	MAX.	MIN.	MIN.		(Ŭ)	WAVEFORWIS	
		-	0.70	-	-	-		1.2		
		0.8	1.10	1.4	0.8	1.4		2.0		
		1.0	1.45	2.0	1.0	2.0		2.7		
$V_{T+}$	Positive-going threshold	1.2	1.60	2.2	1.2	2.2	V	3.0	Figure 1 and 2	
		1.5	1.95	2.4	1.5	2.4		3.6		
		1.7	2.50	3.15	1.7	3.15		4.5		
		2.1	3.00	3.85	2.1	3.85		5.5		
		-	0.34	-	-	-		1.2		
		0.3	0.65	0.9	0.3	0.9		2.0		
		0.4	0.90	1.4	0.4	1.4		2.7		
$V_{T-}$	Negative-going threshold	0.6	1.05	1.5	0.6	1.5	V	3.0	Figure 1 and 2	
		0.8	1.30	1.8	0.8	1.8		3.6		
		0.9	1.60	2.0	0.9	2.0		4.5		
		1.1	2.00	2.6	1.1	2.6		5.5		
		-	0.30	-	-	-		1.2		
		0.2	0.55	0.8	0.2	0.8		2.0		
		0.3	0.60	1.1	0.3	1.1		2.7		
V <sub>H</sub>	Hysteresis (V <sub>T+</sub> – V <sub>T-</sub> )	0.4	0.65	1.2	0.4	1.2	V	3.0	Figure 1 and 2	
	(17 17)	0.4	0.70	1.2	0.4	1.2		3.6		
		0.4	0.80	1.4	0.4	1.4		4.5		
		0.6	1.00	1.5	0.6	1.5		5.5		

### NOTES:

1. All typical values are measured at  $T_{amb} = 25^{\circ}C$ 2. The V<sub>IH</sub> and V<sub>IL</sub> from the DC family characteristics are superseded by the V<sub>T+</sub> and V<sub>T-</sub>.

### **AC CHARACTERISTICS**

GND = 0V;  $t_r \le t_f$  = 2.5ns;  $C_L$  = 50pF;  $R_L$  = 1K $\Omega$ 

SYMBOL PARAMETER			CONDITION		LIMITS					
		WAVEFORM			40 to +85 °	С	<b>−40 to +125</b> °C		UNIT	
		V <sub>CC</sub> (V)		MIN	TYP <sup>1</sup>	MAX	MIN	MAX		
			1.2		80					
	Propagation delay	Propagation delay nA to nY	Figure 6	2.0		27	37		48	
t <sub>PHL/PLH</sub>				2.7		20	28		35	ns
		3.0 to 3.6		15 <sup>2</sup>	22		28			
			4.5 to 5.5			18		23		

### NOTES:

1. Unless otherwise stated, all typical values are measured at  $T_{amb} = 25^{\circ}C$ 2. Typical values are measured at  $V_{CC} = 3.3 \text{ V}$ .

# 74LV14

# TRANSFER CHARACTERISTIC WAVEFORMS $V_{O}$ Vi $V_{\mathsf{H}}$ -≁ $V_{\mathsf{T}+}$ V<sub>T</sub>-SV00427

Figure 1. Transfer characteristic.

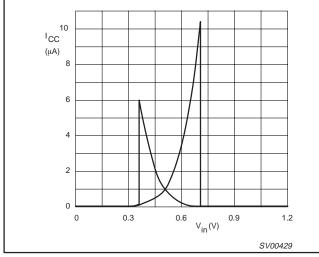


Figure 3. Typical 74LV14 transfer characteristics;  $V_{CC} = 1.2V$ .

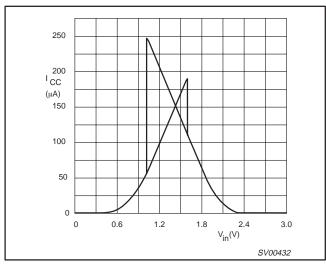


Figure 5. Typical 74LV14 transfer characteristics; V<sub>CC</sub> = 3.0V.

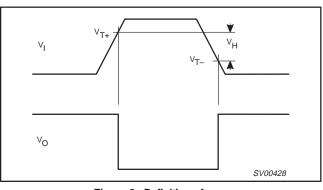


Figure 2. Definition of  $v_{T+}$ ,  $V_{T-}$  and  $V_{H}$ ; where  $V_{T\!+}$  and  $V_{T\!-}$  are between limits of 20% and 70%

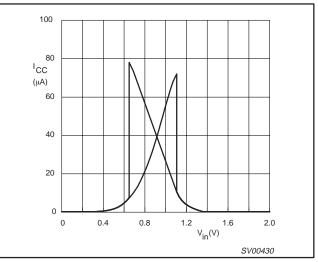


Figure 4. Typical 74LV14 transfer characteristics; V<sub>CC</sub> = 2.0V.

### **AC WAVEFORMS**

 $V_M$  = 1.5 V at  $V_{CC} \geq 2.7$  V;

 $V_M^{}=0.5\times V_{CC}$  at  $V_{CC}$  < 2.7 V  $V_{OL}$  and  $V_{OH}$  are the typical output voltage drop that occur with the output load.

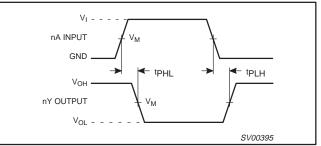


Figure 6. Input (nA) to output (nY) propagation delays.

### Product specification

# 74LV14

### **APPLICATION INFORMATION**

The slow input rise and fall times cause additional power dissipation, this can be calculated using the following formula:

 $\mathsf{P}_{ad} \quad = \mathsf{f}_i \times (\mathsf{t}_r \times \mathsf{I}_{\mathsf{CCa}} + \mathsf{t}_f \times \,\mathsf{I}_{\mathsf{CCa}}) \times \mathsf{V}_{\mathsf{CC}}.$ 

### Where:

 $P_{ad}$  = additional power dissipation ( $\mu$ W)

- f<sub>i</sub> = input frequency (MHz)
- $t_r$  = input rise time (ns); 10% 90%
- $t_f$  = input fall time (ns); 10% 90%
- $I^{}_{CCa}~$  = average additional supply current (µA)

Average  $I_{CCa}$  differs with positive or negative input transitions, as shown in Figure 7.

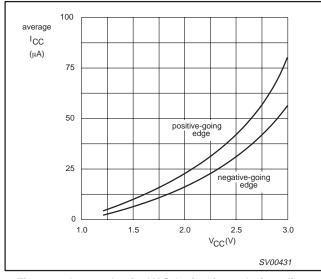


Figure 7. Average I<sub>CC</sub> for LV Schmitt-trigger devices; linear change of V<sub>I</sub> between 0.1 V<sub>CC</sub> to 0.9 V<sub>CC</sub>.

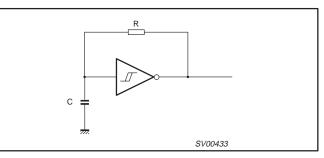
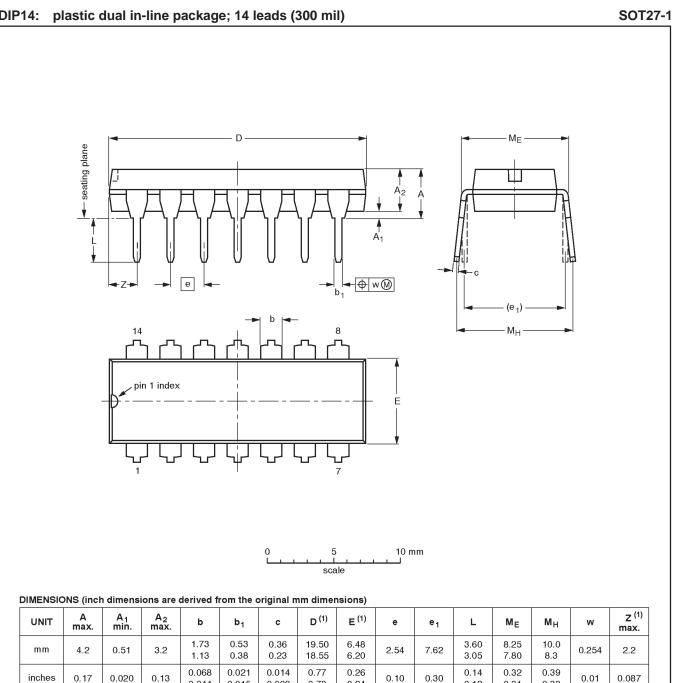


Figure 8. Relaxation oscillator using the LV14.

### Note to application information:

All values given are typical unless otherwise specified. Note to Figure 8

$$f = \frac{1}{T} \approx \frac{1}{0.8 \times RC}$$



## DIP14:

Note

inches

0.17

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

0.044

0.015

0.009

0.13

OUTLINE		EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT27-1	050G04	MO-001AA				<del>-92-11-17</del> 95-03-11

0.24

0.73

0.10

0.30

0.12

0.31

0.33

0.01

0.087

74LV14

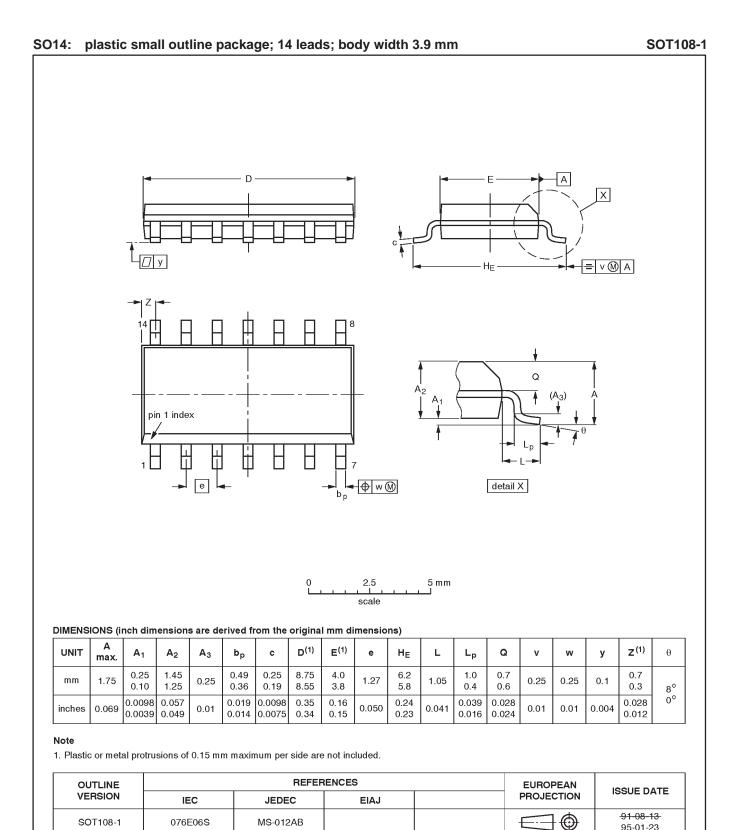
SOT108-1

076E06S

MS-012AB

# Hex inverting Schmitt-trigger

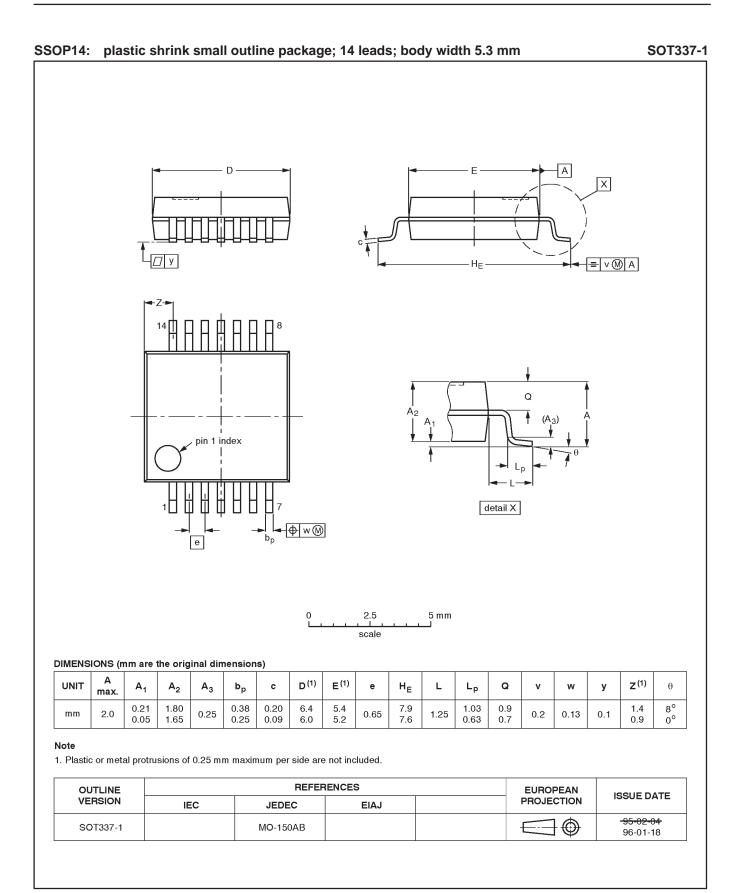
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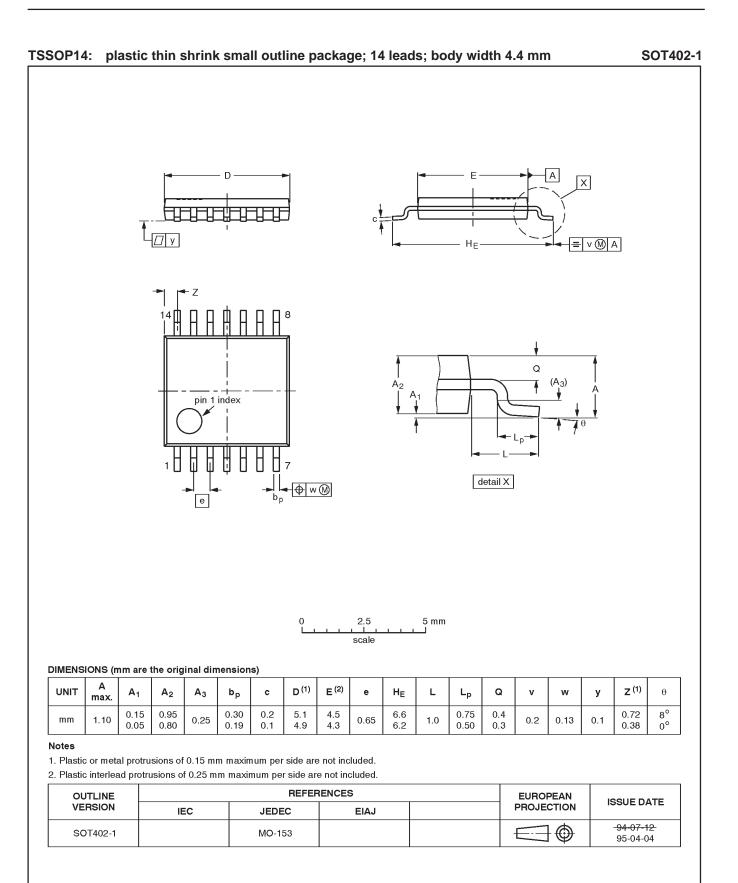
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74LV14



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# 74LV14

DEFINITIONS					
Data Sheet Identification	Product Status	Definition			
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.			
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